


<b>Search Notes</b>  	<b>Application/Control No.</b>  10067350	<b>Applicant(s)/Patent Under Reexamination</b>  FUJII ET AL.
	<b>Examiner</b>  Ba Huynh	<b>Art Unit</b>  2179

SEARCHED			
Class	Subclass	Date	Examiner
715	748, 751, 753, 756, 757, 758	1/27/10	hb

SEARCH NOTES		
Search Notes	Date	Examiner
East searched	10/15/2004	hb
East searched	10/27/04	hb
East searched	7/23/05	hb
East searched	12/31/07	hb

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
715	748, 751, 753, 756, 757, 758	1/27/10	hb

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